

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/829,059	SANCHEZ B. ET AL.
	<b>Examiner</b> Kwang B. Yao	<b>Art Unit</b> 2667

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same as above	6/6/05		KBY